

Search Notes**Application/Control No.**

10/635,516

Examiner

Sheela C. Chawan

Applicant(s)/Patent under Reexamination

MILNE ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
382	124, 116,	11/20/2006	SCC
"	126, 127	11/20/2006	"
"	312,125	11/20/2006	"
720	718	11/20/2006	"
713	186	11/20/2006	"
42	70.11	11/20/2006	"
235	380,382	11/20/2006	"
"	487,492	11/20/2006	"
365	201, 203	11/20/2006	"
"	222,228	11/20/2006	"
"	205,190	11/20/2006	"
"	189.09	11/20/2006	"
382	116, 124	7/31/08	SCC
ABOVE	SEARCH UP-DATE	"	SCC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
382	116,124	7/31/08	SCC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US-PPGPUB, USPAT,EPO,JPO,DERWENT, IBM-TDB.	11/20/2006	SCC
INVENTOR NAME SEARCH	11/20/2006	"
<i>Search by date</i> <i>5/14/07</i> <i>5/14/07</i>	<i>5/14/07</i>	<i>SCC</i>
SEARCH EAST AND OTHER DATA BASE SEE THE SEARCH REPORT PRINT OUT.	7/31/09	SCC
382/116,124,126,127,312, 125.CCLS. US-PATENT TEXT SEARCH.	7/31/08	SCC
INTERFERENCE SEARCH	7/31/08	SCC
SEARCH IEEE OR INSPECT DATABASE.	7/31/08	SCC
ABOVE SEARCH UP-DATE	7/31/08	SCC